## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10695259	TAN, WAI-TIAN
Examiner	Art Unit
Nguyen-Ba, Hoang-Vu A	2421

SEARCHED					
Class		Subclass		Date	Examiner
725	149			8/23/07	HAN

SEARCH NOTES				
Search Notes	Date	Examiner		
East Text Search – USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	8/23/07	HAN		
East Text Search – USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	10/22/08	HAN		
709/220-221, 238-239 text search only	4/3/09	HAN		

	INTERFERENCE SEARCH		
Class	Subclass	Date	Examiner
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